

Notice of References Cited

Application/Control No.

10/661,535

Applicant(s)/Patent Under
Reexamination
HIRAKAWA ET AL.

Examiner

STEPHEN G. SHERMAN

Art Unit

2629

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0050794	05-2002	Ishizuka, Mitsuhiro	315/169.3
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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